

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : National Phase Entry of PCT/DE2004/002160  
Applicant : Dieter HUHSE et al  
Filed : March 23, 2006  
TC/A.U. :  
Examiner :

Docket No. : 3286-103  
Customer No. : 6449  
Confirmation No.:

**INFORMATION DISCLOSURE STATEMENT**

Director of the United States Patent  
and Trademark Office  
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Alexandria, VA 22313-1450

Sir:

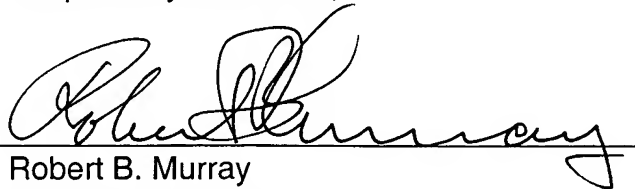
In compliance with applicants duty of disclosure under 37 C.F.R. 1.56, enclosed is a copy of the International Search Report in the corresponding international application. The relevance of some the references is noted in the International Search Report and copies of the references are provided herewith for Examiner's review.

US 2004/0051926A1 is the English Equivalent of DE 100 47 170 A1.

Please charge any fee deficiency or credit any overpayment to Deposit Account No. 02-2135.

Respectfully submitted,

By



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RBM/cb

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>				<i>Complete if Known</i>	
				Application Number	New Application
				Filing Date	March 23, 2006
				First Named Inventor	Dieter HUHSE et al
				Group Art Unit	
				Examiner Name	
				Confirmation No.	
Sheet	1	of	3	Attorney Docket Number	3286-103

[illegible]

<sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code. <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.



1/23/2006

March 2006

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>				<i>Complete if Known</i>	
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Sheet	3	of	3	Attorney Docket Number	3286-103

NON PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>2</sup>	
	12.	Schimpe et al., "Characterisation of Frequency Response of 1.5 MUM INGAASP DFB Laser Diode and INGAAS...", ELECTRONICS LETTERS, vol. 22, no. 9, April 24, 1986, pgs. 453-454.		
	13.	Reimann et al., "Advanced semiconductor laser based electro-optical sampling system using soliton pulse compression for direct probing at 1.55-/spl mu/m wavelength", LASERS AND ELECTRO-OPTICS SOCIETY ANNUAL MEETING, 1988, vol. 1, December 1, 1998, pgs. 215-216.		
	14.	Reimann et al., "Low jitter dual semiconductor laser system using electrical phase shift for fast temporal scanning in time-resolved pump and probe experiments", LASERS AND ELECTRO-OPTICS, 1999, vol. 2, August 30, 1999, pgs. 203-204.		
Examiner Signature				Date Considered

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